Applicant(s)/Patent Under Application/Control No. Reexamination 10/629,260 FAYE ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 Mark Ruthkosky 1745 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,041,344 08-1991 Kamoshita et al. Α 429/26 US-4,622,275 11-1986 Noguchi et al. 429/19 В С US-US-D US-Ε US-F US-G US-Н US-US-J Κ US-US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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